

Search Notes

Application/Control No.

10/628,228

Examiner

Alex Liew

Applicant(s)/Patent under
Reexamination

TAKENAKA, HIDEKI

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/118 (limited to text search)	10/5/2006	AL
382/118 limited to text search	2/7/2007	AL